## Antenna-Coupled TES Array Development in Astrophysical Applications

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## Overview

- Instrumentation requirements in Cosmic Microwave Background (CMB) polarization anisotropy
- Cryogenic detectors
- Antenna-coupled TES array architecture and characterization at Caltech/JPL
- TES array multiplexing and systematic issues
- Cryogenic detectors development at Argonne Lab
- Summary

## Tools in Understanding the Universe

- Theories
  - Big Bang
  - Inflation
  - Baryogenesis
  - Nucleosynthesis
  - Recombination
  - Star formation, then galaxies, clusters of galaxies, ...
- Tests
  - Hubble's law
  - Nucleosynthesis data
  - Structure formation history
  - Cosmic Microwave Background (CMB)



Image from WMAP press release

## Status of CMB Observations

- CMB Blackbody Temperature Observed  $\checkmark$ 
  - ☑ Well Characterized
- CMB Temperature Anisotropy Observed  $\checkmark$ ☑ Well Characterized
- **CMB E-mode Polarization** •
  - ☑ Observed (DASI, B03, CBI, CAPMAP, QUAD, WMAP)
  - Not Well Characterized
- **CMB B-mode Polarization** 
  - Not observed, Possible by Planck, SPIDER, and SPTpol in future
  - Not Characterized



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#### Why CMB B-mode Polarization Measurement?

- •The fingerprint at the time of inflation (10<sup>-35</sup> s) is encoded on the cosmic gravitationalwave background (CGB)
- •Exploration and test of high energy physics in GUT
- •CGB stretches and compresses spacetime on the surface of last scattering -- transmitting this information as a curl component in the polarization



$$r = \frac{T^2}{S^2} \propto \left(\frac{E_I}{M_{pl}}\right)^2$$

## **Detector Sensitivity for CMB B-Modes**

- CMB temperature
- CMB anisotropy angular power spectrum
- CMB polarization anisotropy angular power spectra
  - E-modes
  - B-modes

Increasing difficulty

$$\langle T \rangle = 2.725K$$

$$\Delta T_{rms} \sim 20 \mu K$$

$$\Delta T_{E,rms} \sim 2\mu K$$

$$\Delta T_{B,rms} \leq 0.1 \mu K$$

## **CMB** Detectors

- Interferometric
  - measuring microwave electric field amplitude and phase at the same time
  - n-antennas (or telescopes), number of correlated channels is proportional to  $n^2$
  - Moderate noise level  $\sim 1 m K \ Hz^{-0.5}$  for each antenna, and instrument sensitivity inversely scales with n
  - $4 \sim 20 \; K$
- Coherent
  - Feed horns or waveguides, then OMT
  - Noise level is moderate: WMAP, 0.65 mK Hz<sup>-0.5</sup> at K; 1.48 mK Hz<sup>-0.5</sup> at W
  - $\ 4\sim 20 \ K$
- Bolometric
  - Measuring microwave electric field amplitude
  - Feed horns or wave guides could be removed
  - Noise level is low,  $0.1 \sim 0.2$  mKHz<sup>-0.5</sup>, as low as 0.03 mKHz<sup>-0.5</sup> in space operated below 0.1K
  - Large format receivers array with a single telescope
  - Below 1 K, cryogenic detectors



#### **TES Detectors**



- Conventional superconductor film
- Voltage bias with a negative feedback
- Temperature change is converted to a current change

$$C\frac{dT}{dt} = P_B - G(T - T_b) + Q\delta(t)$$

$$\Delta I \approx -\frac{Q}{C} \frac{\alpha \cdot I_{TES}}{T} \exp\left(-\frac{t}{\tau}\right)$$

$$\tau \approx \frac{C}{G} \frac{1}{1+g} \qquad g = \frac{P_B \alpha}{GT}$$

$$S(\omega) \approx \frac{1}{V_B} \frac{1}{1 + i\omega\tau}$$

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## Why TES Detectors?

- High performance thermometer
  - Sharp superconducting transition, good sensitivity
  - Voltage bias (electro-thermal feedback)
    - linear broad band response: up to a few tens kHz
    - Fast response time: a few tens  $\mu$ s ~ a few tens ms
    - Modest variations in Tc across wafer are accommodated
  - Low dissipation: TES + shunt resistor  $\sim 0.1$ nW
  - Low noise  $NEP \sim 10^{-18} W / \sqrt{Hz}$
- Low impedance devices
  - Immune to microphonic noise
  - Impedance matching to SQUID amplifier's dynamic resistance
- Applications
  - Calorimeter and micro-calorimeters: particle detectors, for example CDMS; improved energy dispersive spectrometer in material science; constellation X-ray in astrophysics; radiation remote sensing
  - Bolometers: UV, visible, infrared, and millimeter photons

### Review of Noise in CMB Measurement

- Noise specified as Noise Equivalent Power (NEP), power incident on detector that can be detected at  $1\sigma$  in 1 sec, units of W Hz<sup>-0.5</sup>
  - -detector noise: phonon noise, Johnson noise of resistors, amplifier noise.
  - -Background Limited Infrared Photodetector (BLIP) noise: shot noise on DC optical load
  - -sky noise: variations in sky loading
- These yield Noise Equivalent Flux Density (NEFD): flux density (Jy) that can be detected at 1 $\sigma$  in 1 sec, NEFD =  $\frac{\text{NEP}}{\eta A \Delta \nu}$ units of Jy Hz<sup>-0.5</sup>
- Beam size defines Noise Equivalent Surface Brightness (NESB), units of (Jy/arcmin<sup>2</sup>) Hz<sup>-0.5</sup>
- Can then calculate Noise Equivalent Temperature (NET<sub>CMB</sub>), units of (µK<sub>CMB</sub>/beam) Hz<sup>-0.5</sup>
- For diffraction limited optics And at Rayleigh – Jeans limit

 $\mathrm{NESB} = \frac{\mathrm{NEFD}}{\Omega_{\mathrm{beam}}}$ 

$$\text{NET}_{\text{CMB}} = \text{NESB} \left( \left. \frac{dI_{\nu}}{dT} \right|_{T_{\text{CMB}}} \right)^{-1}$$

NET 
$$_{CMB} \approx \frac{NEP}{2k_B \eta \Delta \nu}$$

## Need Large Bolometer Array

- TES bolometers are operated at 100~300mK
- Current fully instrumented bolometer NEP at 1e-18 W Hz<sup>-0.5</sup>
- Photon noise NEP at about 5~8e-18 W Hz<sup>-0.5</sup> in space, and about 1e-17 W Hz<sup>-0.5</sup> near ground
- These can be transferred to CMB measurement sensitivity of  $50 \sim 200 \ \mu K_{CMB} \ Hz^{-0.5}$ , which depends on bolometers operation temperature, instrumentation configuration, and frequencies
- To reach 1  $\mu$ K<sub>CMB</sub> Hz<sup>-0.5</sup> for B-mode CMB detection, 1000 or more bolometers are needed at each specific frequency band
- Compact photolithographic antenna-coupled TES bolometer large array

## Large Detector Array

Antenna arrays (Caltech/JPL) Spider/SPUD Extended Hemispherical Lens Antenna Lenslets (Berkeley) Substrate Polarbear **QUIE**T **Platelets** (U of C)

## Multi – bands for Foreground Subtraction



Task Force Report on CMB Research

For r = 0.01, more than 10 fold background reduction needed

Need multi-frequency bands for foreground subtraction

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## SPIDER: Balloon Borne Flight

CMB polarization B-mode measurement pathfinder: a large angular scale millimeter wave polarimeter with antenna-coupled TES large format arrays suitable for multiplexing



| Observing                      | Band                       | Beam                       | Number                            | Number                                   | Single Detector                         | Instrument                              |
|--------------------------------|----------------------------|----------------------------|-----------------------------------|--|---|---|
| Band                           | width                      | FWHM                       | of Spatial                        | of                                       | Sensitivity                             | Sensitivity                             |
| (GHz)                          | (GHz)                      | (arcmin)                   | Pixels                            | Detectors                                | (µK <sub>CMB</sub> Hz <sup>-0.5</sup> ) | (µK <sub>CMB</sub> Hz <sup>-0.5</sup> ) |
| 80<br>100<br>145<br>225<br>275 | 19<br>24<br>35<br>54<br>66 | 72<br>58<br>40<br>26<br>21 | 100<br>2×144<br>256<br>256<br>256 | 200<br>2×288<br>512<br>512<br>512<br>512 | 110<br>100<br>100<br>204<br>351         | 7.8<br>4.2<br>4.4<br>9.0<br>15.5        |

Assume the overall optical efficiency 50%. Operated at 250mK

#### **Format Receiver Arrays**

#### The state-of-the-art:

- Discrete elements: feeds, filters, detectors
- Massive and expensive, hand-assembled
- Low packing efficiency
- Individual JFET readout with moderate noise



**BICEP focal plane (98 detectors)** Oct-15-07

#### The future:

- Integrating all components on a Si wafer
- Compact, inexpensive, photolithographic
- High packing density
- TES low impedance enables SQUID multiplexed read-out with low noise



Antenna-coupled TES array (256 Q/U detectors)

#### 150 GHz Dual Polarization Antenna Coupled TES



### Single Polarization Antenna Architecture



- Long slot antennas on the Nb ground plane provide beam collimation
- low loss Nb microstrip is coupled to slot antenna with stubs or vias
- Tapered Nb binary sum tree transport microwave to filters and detectors
- 50~500 GHz achievable
- Evaporated dielectric SiO
- Compact planar design with contact microfabrication

#### Filter

- Lithographic LC filter defines the band pass
- Nb (ground plane) SiO Nb (microstrip elements) structure
- 25% Bandwidth



Designed by A. Goldin

#### Bolometer

- Bolometer released by deep reactive ion etch
- Nitride legs support nitride membrane island
- Lossy metal microstrip as termination wide bandwidth
- Superconducting transition edge sensor
- Quick thermalization time, fast bolometer relaxation time constant





## Microstrip Loss

- Tested with SIS junctions at 4.2K and 1.5K
- The loss tan is  $1.2\pm0.3\times10^{-3}$
- The amplitude 1/e attenuation length is 30~40cm, corresponding about 12% loss for 100 GHz detector
- The main loss comes from dielectric (two level systems)



100 GHz test chip with 11.4 mm long Nb/SiO/Nb microstrip stub. A. Vayonakis

#### Wide Band Termination



- The meandering absorbing microstrip has > 99% absorbing efficiency over 30% bandwidth
- Very tolerant to fabrication variations, e.g., thickness or resistivity

### Nitride Legs



 $g_0 = \pi^2 k_b^2 T / 3h \sim 1 \text{pW/K}^2 \times T$  SPIDER G/g<sub>0</sub> = 10-50 at 250 mK Oct-15-07 Fermi Lab 23

## Microfabrication

- Metallization
  - UHV sputter deposition systems
  - Current materials set: Nb, Al, Ta, Mo, Ti, Cu, Au, NbN, NbTiN
- Dielectric
  - LPCVD low stress silicon nitride
  - Sputtered SiO2 with substrate bias and O2 compensation.
  - Evaporated SiO.
- Lithography
  - Stepper  $\lambda$ =248nm, 0.25 $\mu$ m resolution
  - Contact lithography:  $\lambda$ =436, 365, 320 nm
- Etch
  - 1 Chlorine chemistry, 1 Fluorine chemistry 75mm, 100mm, 150mm wafers
  - STS deep trench reactive ion etcher DRIE

### Multi-layer Structure Processing

|    | Layer                   | <b>Etch/Lift-off</b> | Material                | Thickness |  |
|----|-------------------------|----------------------|-------------------------|-----------|--|
| 1. | Support legs pre        |                      | $Si_3N_4$               | 1000nm    |  |
| 2. | Ti-TES                  | $CCl_2F_2/O_2$ etch  | Ti                      | 250nm     |  |
| 3. | Protect                 | $CHF_3/O_2$ etch     | SiO or SiO <sub>2</sub> | 150nm     |  |
| 4. | Ground Plane            | $CCl_2F_2/O_2$ etch  | Nb                      | 150nm     |  |
| 5. | ILD                     | $CHF_3/O_2$ etch     | SiO or SiO <sub>2</sub> | 300nm     |  |
| 6. | Resistor                | Lift-off             | Au                      | 150nm     |  |
| 7. | <b>Resistor Protect</b> | Lift-off             | SiO                     | 150nm     |  |
| 8. | Microstrip              | $CCl_2F_2/O_2$ etch  | Nb                      | 400nm     |  |
| 9. | FSN                     | $BCl_3/Cl_2$ etch    | Al                      | 500nm     |  |

Metallization

Dielectric

#### **TES Uniformity**



- TES transition temperature could change dramatically with metal film thickness and the contents of impurity contaminations
- Increase sputtering gun (target) radius, could control the superconducting film thickness uniformity with other sputtering parameters tuning
- Devoted facility to avoid impurity contaminations
- The target is to control Tc within 95% for Ti

#### Detectors Performance (Dark Tests)

- Mo/Au bilayer, Tc  $\sim 220 \ mK$
- $G \sim 1 p W/K$
- NEP ~  $3 \times 10^{-19}$  W Hz<sup>-1/2</sup>  $\propto \sqrt{4k_B GT^2}$
- 1/f knee < 1 Hz
- Rolling off frequency 800Hz  $\propto G/C$

- $\bullet$  Ti/Al dual transitions, Tc  $\sim 450~mK$
- $G\sim 50~pW/K$
- NEP ~  $2x10^{-17}$  W Hz<sup>-1/2</sup>
- 1/f knee ~ 50 mHz
- Rolling off frequency > 1000Hz



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#### Antenna-Coupled TES Test facility



- 3 stage He absorption refrigerator with base temperature of 220mK
- Niobium shielding
- Optical windows
- Internal black body for optical efficiency test
- AC resistance bridges for thermometry
- PID temperature control
- Six channels of quantum physics SQUIDs
- Lock-ins: Stanford research
- Fourier transformation spectrometer
- Home made beam mapper

### **Test Tasks**

- Tc measurements
- Antenna beam characterization
- Antenna spectrum and band pass filter characterizations
- Optical efficiency of antennacoupled TES detectors





## Beam of Antenna

- Thermal source
- Two dimensional • mapping
- $13.6^{\circ} \pm 0.1^{\circ}$ • Gaussian beam at FWHM
- Ellipticity < 3%ullet
- Cross polarization < 5%
- Low sidelobes (out of view here)

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## **Optical Efficiency Test**





- Cold blackbody in Dewar
- $4K \sim 20K$
- Slope is used to normalize the spectra
- $G\sim 500~pW/K$  at 0.9 K

#### Spectra



- Wide band single polarization antenna: low optical efficiency and fringes caused by feed network
- Dual polarization antenna has usable bandwidth ~ 20%; high optical efficiency
- The lumped element filters produce satisfying band ~ 30%, no leaks



#### 145 GHz Dual-Pol Antenna Array



- New design with HFSS simulation (Goutam Chattopadhyay) and moment method calculation (Peter Day)
- Reduced cross polarization
- Increased band width
- High impedance (~ 40  $\Omega$ ), Nb transition line is really narrow

### Antenna Impedance Plot



- At the resonance (Im Z = 0), the feed sees a simple resistive load
- The feed transmission line needs to match the impedance of this load
- Short slots are more compact, but could reduce transmission microstrip width to below 1µm due to high impedance of the slot antenna

#### New Dual-pol Antenna





#### New Antenna – coupled TES

y (deg)

- Molybdenum gold bi-layer TES, Tc is between 450 mK and 500 mK
- Spectra without filters look good, band width is over 30%
- Filter's band pass is clean
- Optical efficiency is at 60% level
- Cross polarization < 2%
- Nice beam, ellipticity < 3%





-20 -10 0 10 20 x (deg)

## Single Tile Focal Plane for Array Test

**Array location with** 8x8 = 64 pixels 8x8x4 = 256 readouts



**SQUIDs** 

#### **Time-Division Multiplexing**

De Korte et al., NIST



## Excess noise control

- Magnetic field could cause significant noise in TES and SQUID
  - Vortex motion in TES film
  - Trapped flux of DC field in SQUID
  - Trapped flux motion due to strayed AC field in SQUID
- Sources of field: Earth's field, waveplate motor, electronics, etc
- SQUID is very sensitive to magnetic field, to reach 1µKrts sensitivity, magnetic field need be controlled below 5nT
- Magnetic field effect in TES is about 1.5mK/Gauss, TES with voltage bias requires magnetic field below  $1\mu T$
- Multilayer magnetic shielding: cryoperm + niobium tube
- Excess noise appears at low bias of TES

## Multicolor Frequency Selective TES array

Part of SPEectral Energy Distribution (SPEED) project to study the spectral energy distribution of high red-shift galaxies. The star formation in the early universe
4 x 4 pixel array operating @ sub 0.5 K temperatures; each pixel is a frequency selective bolometers stack that enables sensing radiation at 150, 220, 270, 350GHz
Simultaneous spatial and spectral measurements
Efficient use of focal plane area



## Absorber Type Polarimeter



Simulation for 95GHz 14stripes, length 1.660mm, width  $3\mu m$ , R=7 $\Omega$ /sq

$$Z \approx R \frac{L}{W(N+1)}$$





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# Integrated large array for Q/U measurements



PAPPA, Xpol < -45dB







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## Current Status and Future Plan at ANL

- Frequency selective bolometers for SPEED
  - Micro-fabrication of prototype array;
  - Dark and optical measurements, noise characterization;
  - Device assembling for ground telescope observation
- Polarimeters for SPT
  - Simulation and design (HFSS)
  - Thermal modeling and G tuning
  - Microfabrication of prototype devices
  - Dark and optical measurements
  - Noise characterization
  - Horn coupled large format polarimeters array (thousands of pixels) in polarization-sensitive measurements for the SPT observations
- Enhancing micro-fabrication capability
- SQUID-based multiplexing read-out for detectors array
- New applications, for example, X-ray dispersive fluorescence analysis

## Summary

- Antenna-coupled TES bolometer technology has been demonstrated
- Large format arrays will instrument a balloon borne CMB experiment -- SPIDER, and an upgraded south pole CMB experiment (BICEP) -- SPUD
- Large format array technology is competitive for future space experiment CMBpol
- Detector technology efforts at ANL, such as frequency selective bolometers and absorber type polarization sensitive bolometers

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- U of C J. E. Carlstrom, C. Cheng, T. Downes, J. McMahon, S. S. Meyer





#### **B-mode** Lensing



#### W. Hu and T. Okamoto, ApJ 2002

$$NEP_{BLIP} = \sqrt{\sum \left[2P_i \left(h\overline{\nu} + \varepsilon_i \eta_i k_B T_i\right)\right]}$$

The first term is the contribution from photon random arrivals (shot noise due to Poisson statistics). The second term accounts for the effect of photon correlation and depends on the source emissivity and temperature, and the net efficiency through the optics to the detector

$$A = \left(\frac{4n}{(n+1)^2}\right) \frac{4nZ_0R_0}{((n+1)R_0 + Z_0)^2}$$

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